## DM8827/DM8857 Burn-In & Test System

DM8857 & DM8827 are most efficient Burn-in & Test system for product Quality Assurance purpose. It provides flexible zone for various testing requirements, fitted for sophisticated testing conditions. Based on its successful base model, AF8652 series system, it continues to provide best solutions with utmost confidence.

- Fail memory to analyze fail
- Extended functional design for Memory SER test requirements
- 4 independently controlled chambers (Temperature, Testing Device)
- Flash Test : DM8827 only
- Number of Zone : 4zones (1zone / oven)
- Number of Slot: 16Slots (4Slots / zone)
- Temp. Control : -50 °C ~ + 150 °C (20vens)
- RT~ + 150  $^{\circ}$ C (2ovens) - Temp. Accuracy:  $\pm 3^{\circ}$ C (-10  $^{\circ}$ C ~ + 125  $^{\circ}$ C)
  - ±5°C (-50°C~-10°C, +125°C~+150°C)
- ALPG address

DM8857 : Zone 1 : 44bits (X:22bits, Y: 22bits) Zone 2~4 : 36bits (X:18bits, Y: 18bits)

DM8827 : Zone 1~4 : 44bits (X:22bits, Y: 22bits)



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